

## 74LCX07

### Low Voltage Hex Buffer with Open Drain Outputs

#### General Description

The LCX07 contains six buffers. The inputs tolerate voltages up to 7V allowing the interface of 5V systems to 3V systems.

The outputs of the LCX07 are open drain and can be connected to other open drain outputs to implement active HIGH wire AND or active LOW wire OR functions.

The 74LCX07 is fabricated with advanced CMOS technology to achieve high speed operation while maintaining CMOS low power dissipation.

#### Features

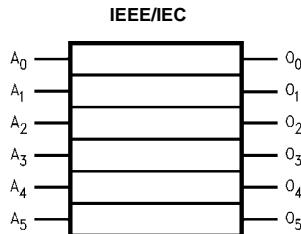
- 5V tolerant inputs
- 2.3V–5.5V  $V_{CC}$  specifications provided
- 2.9 ns  $t_{PD}$  max ( $V_{CC} = 3.3V$ ), 10  $\mu A$   $I_{CC}$  max
- Power down high impedance inputs and outputs
- $\pm 24$  mA output drive ( $V_{CC} = 3.0V$ )
- Implements patented noise/EMI reduction circuitry
- Latch-up performance exceeds 500 mA
- ESD performance:  
Human body model > 2000V  
Machine model > 200V

#### Ordering Code:

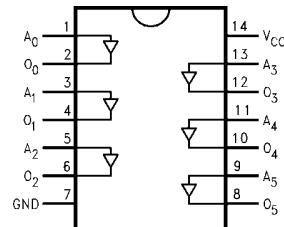
Order Number	Package Number	Package Description
74LCX07M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow
74LCX07SJ	M14D	14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74LCX07MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

#### Logic Symbol



#### Connection Diagram



#### Pin Descriptions

Pin Names	Description
$A_n$	Inputs
$O_n$	Outputs

### Absolute Maximum Ratings (Note 1)

Symbol	Parameter	Value	Conditions	Units
$V_{CC}$	Supply Voltage	-0.5 to +7.0		V
$V_I$	DC Input Voltage	-0.5 to +7.0		V
$V_O$	DC Output Voltage	-0.5 to $V_{CC} + 0.5$	Output in HIGH or LOW State (Note 2)	V
$I_{IK}$	DC Input Diode Current	-50	$V_I < GND$	mA
$I_{OK}$	DC Output Diode Current	-50 +50	$V_O < GND$ $V_O > V_{CC}$	mA
$I_O$	DC Output Source/Sink Current	$\pm 50$		mA
$I_{CC}$	DC Supply Current per Supply Pin	$\pm 100$		mA
$I_{GND}$	DC Ground Current per Ground Pin	$\pm 100$		mA
$T_{STG}$	Storage Temperature	-65 to +150		°C

### Recommended Operating Conditions (Note 3)

Symbol	Parameter	Min	Max	Units
$V_{CC}$	Supply Voltage	Operating Data Retention	2.0 1.5	V
$V_I$	Input Voltage	0	5.5	V
$V_O$	Output Voltage	HIGH or LOW State	0	$V_{CC}$
$I_{OL}$	Output Current	$V_{CC} = 4.5 - 5.5V$ $V_{CC} = 3.0V - 3.6V$ $V_{CC} = 2.7V - 3.0V$ $V_{CC} = 2.3V - 2.7V$	+32 +24 +12 +8	mA
$T_A$	Free-Air Operating Temperature	-40	85	°C
$\Delta t/\Delta V$	Input Edge Rate, $V_{IN} = 0.8V - 2.0V$ , $V_{CC} = 3.0V$	0	10	ns/V

Note 1: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The Recommended Operating Conditions table will define the conditions for actual device operation.

Note 2:  $I_O$  Absolute Maximum Rating must be observed.

Note 3: Unused inputs must be held HIGH or LOW. They may not float.

### DC Electrical Characteristics

Symbol	Parameter	Conditions	$V_{CC}$ (V)	$T_A = -40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$		Units
				Min	Max	
$V_{IH}$	HIGH Level Input Voltage		2.3 - 2.7	1.7		V
			2.7 - 3.6	2.0		
			4.5 - 5.5	0.7 x $V_{CC}$		
$V_{IL}$	LOW Level Input Voltage		2.3 - 2.7		0.7	V
			2.7 - 3.6		0.8	
			4.5 - 5.5		0.3 x $V_{CC}$	
$V_{OL}$	LOW Level Output Voltage	$I_{OL} = -100 \mu\text{A}$ $I_{OL} = 8 \text{ mA}$ $I_{OL} = 12 \text{ mA}$ $I_{OL} = 16 \text{ mA}$ $I_{OL} = 24 \text{ mA}$ $I_{OL} = 32 \text{ mA}$	2.3 - 5.5		0.2	V
			2.3		0.6	
			2.7		0.4	
			3.0		0.4	
			3.0		0.55	
			4.5		0.55	
$I_I$	Input Leakage Current	$0 \leq V_I \leq 5.5V$	2.3 - 5.5		$\pm 5.0$	μA
$I_{OFF}$	Power-Off Leakage Current	$V_I$ or $V_O = 5.5V$	0		10	μA
$I_{CC}$	Quiescent Supply Current	$V_I = V_{CC}$ or GND	2.3 - 5.5		10	μA
		$3.6V \leq V_I \leq 5.5V$	2.3 - 5.5		$\pm 10$	
$\Delta I_{CC}$	Increase in $I_{CC}$ per Input	$V_{IH} = V_{CC} - 0.6V$	2.3 - 3.6		500	μA
			4.5 - 5.5		1	

## AC Electrical Characteristics

Symbol	Parameter	$T_A = -40^\circ\text{C}$ to $+85^\circ\text{C}$ , $R_L = 500\Omega$								Units	
		$V_{CC} = 5.0\text{V} \pm 0.5\text{V}$		$V_{CC} = 3.3\text{V} \pm 0.3\text{V}$		$V_{CC} = 2.7\text{V}$		$V_{CC} = 2.5\text{V} \pm 0.2\text{V}$			
		$C_L = 50 \text{ pF}$		$C_L = 50 \text{ pF}$		$C_L = 50 \text{ pF}$		$C_L = 30 \text{ pF}$			
		Min	Max	Min	Max	Min	Max	Min	Max		
$t_{PZL}$	Propagation Delay Time	0.5	3.0	0.8	3.7	1.0	4.4	0.8	3.8	ns	
$t_{PLZ}$		0.5	3.0	0.8	3.7	1.0	4.4	0.8	3.8		

Note 4: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW ( $t_{OSHL}$ ) or LOW-to-HIGH ( $t_{OSLH}$ ).

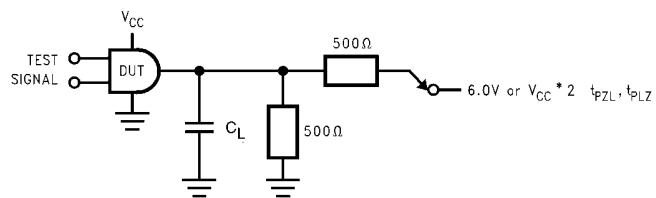
## Dynamic Switching Characteristics

Symbol	Parameter	Conditions		$V_{CC}$ (V)	$T_A = 25^\circ\text{C}$	Units
					Typical	
$V_{OLP}$	Quiet Output Dynamic Peak $V_{OL}$	$C_L = 50 \text{ pF}, V_{IH} = 3.3\text{V}, V_{IL} = 0\text{V}$		3.3	0.9	V
		$C_L = 30 \text{ pF}, V_{IH} = 2.5\text{V}, V_{IL} = 0\text{V}$		2.5	0.7	
$V_{OLV}$	Quiet Output Dynamic Valley $V_{OL}$	$C_L = 50 \text{ pF}, V_{IH} = 3.3\text{V}, V_{IL} = 0\text{V}$		3.3	-0.8	V
		$C_L = 30 \text{ pF}, V_{IH} = 2.5\text{V}, V_{IL} = 0\text{V}$		2.5	-0.6	

## Capacitance

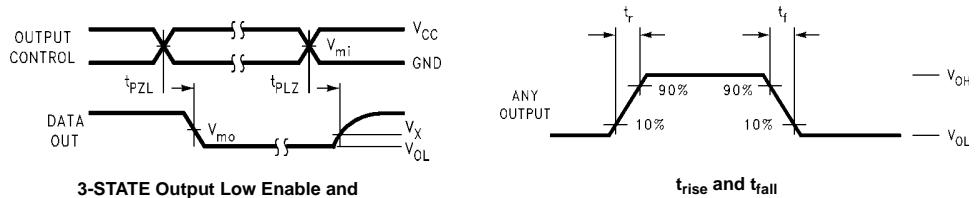
Symbol	Parameter	Conditions	Typical	Units
$C_{IN}$	Input Capacitance	$V_{CC} = \text{Open}, V_I = 0\text{V}$ or $V_{CC}$	7	pF
$C_{OUT}$	Output Capacitance	$V_{CC} = 3.3\text{V}, V_I = 0\text{V}$ or $V_{CC}$	8	pF
$C_{PD}$	Power Dissipation Capacitance	$V_{CC} = 3.3\text{V}, V_I = 0\text{V}$ or $V_{CC}, f = 10 \text{ MHz}$	25	pF

## AC Loading and Waveforms



**FIGURE 1. AC Test Circuit**  
( $C_L$  includes probe and jig capacitance)

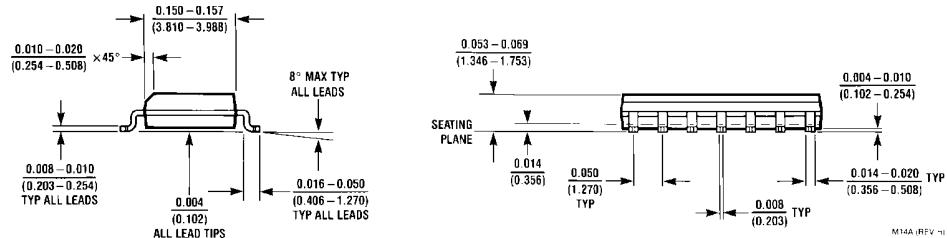
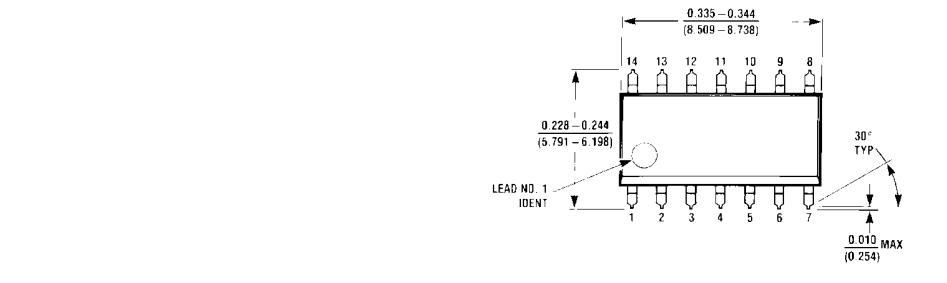
Test	Switch
$t_{PZL}, t_{PLZ}$	$V_{CC} \times 2$ at $V_{CC} = 5.0 \pm 0.5V$ $6V$ at $V_{CC} = 3.3 \pm 0.3V$ $V_{CC} \times 2$ at $V_{CC} = 2.5 \pm 0.2V$



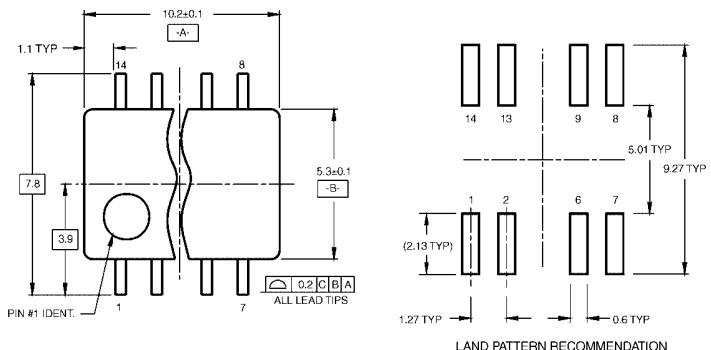
**FIGURE 2. Waveforms**  
(Input Pulse Characteristics;  $f = 1MHz$ ,  $t_r = t_f = 3ns$ )

Symbol	$V_{CC}$			
	$5.0V \pm 0.5V$	$3.3V \pm 0.3V$	$2.7V$	$2.5V \pm 0.2V$
$V_{mi}$	$V_{CC}/2$	1.5V	1.5V	$V_{CC}/2$
$V_{mo}$	$V_{CC}/2$	1.5V	1.5V	$V_{CC}/2$
$V_x$	$V_{OL} + 0.3V$	$V_{OL} + 0.3V$	$V_{OL} + 0.3V$	$V_{OL} + 0.15V$
$V_y$	$V_{OH} - 0.3V$	$V_{OH} - 0.3V$	$V_{OH} - 0.3V$	$V_{OH} - 0.15V$

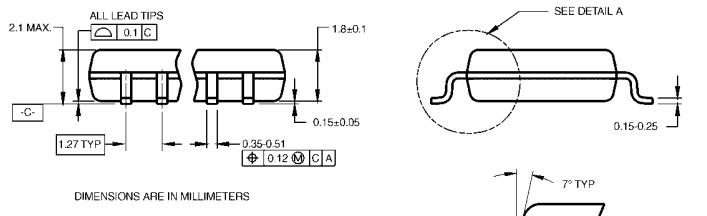
**Physical Dimensions** inches (millimeters) unless otherwise noted



14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-120, 0.150" Narrow  
Package Number M14A



LAND PATTERN RECOMMENDATION

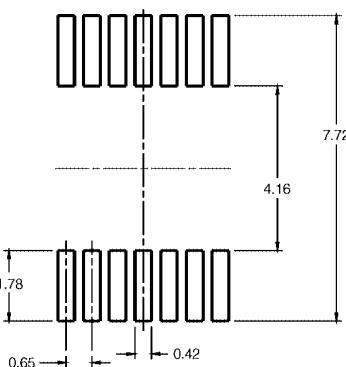
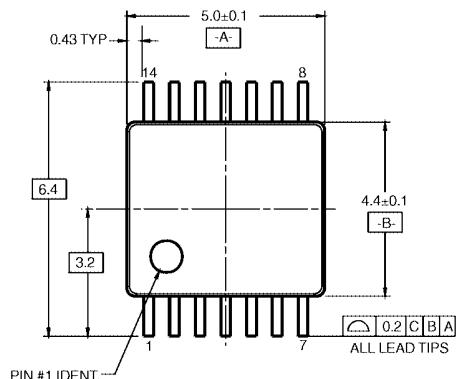


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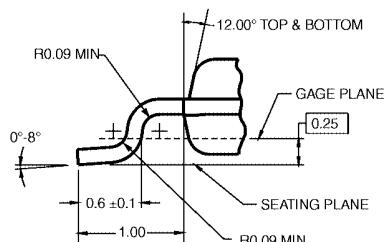
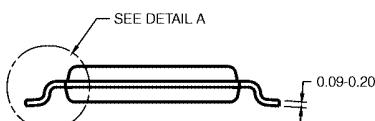
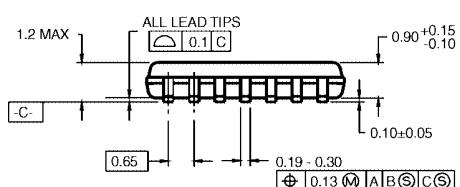
14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide  
Package Number M14D

## 74LCX07 Low Voltage Hex Buffer with Open Drain Outputs

### Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



LAND PATTERN RECOMMENDATION



DETAIL A

**14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide  
Package Number MTC14**

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